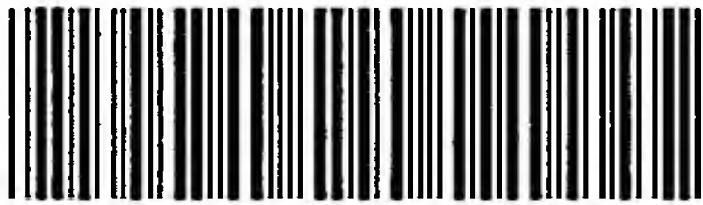


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,461	CHEN ET AL.	
	Examiner	Art Unit	
	Fahmida Rahman	2116	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPAT, USPGPUB, EPO, JPO, USOCR, DERWENT, IBM_TDB	2/17/2006	FR
please see attached		